

Search Notes



Application/Control No.

10/694,319

Examiner

Randall Chin

Applicant(s)/Patent under Reexamination

CHEN, FU YU

Art Unit

1744

SEARCHED

| Class | Subclass | Date | Examiner |
|----------------|----------|------------|----------|
| 15 | 179 | ↓ | ↓ |
| 15 | 182 | 10/25/2005 | RC |
| UPDATED SEARCH | | 2/14/06 | RC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|---------------|----------|---------|----------|
| SAME AS ABOVE | | 2/14/06 | RC |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|------------------------------|------------|------|
| EAST, OCR, DERWENT, EPO, JPO | ↓ | ↓ |
| Inventor name search | 10/25/2005 | RC |
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